

<b>Notice of References Cited</b>	Application/Control No. 09/413,694	Applicant(s)/Patent Under Reexamination PARK, TAE-SAN	
	Examiner BINH K. TIEU	Art Unit 2643	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,553,122 B1	04-2003	Shimauchi et al.	381/66
*	B	US-6,266,422 B1	07-2001	Ikeda, Shigeji	381/71.11
*	C	US-6,256,384 B1	07-2001	Trump, Tonu	379/406.08
*	D	US-6,219,418 B1	04-2001	Eriksson et al.	379/406.08
*	E	US-5,329,472 A	07-1994	Sugiyama, Akihiko	708/322
*	F	US-US00RE358W	08-1998	Shimauchi et al.	381/66
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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